

<b>Notice of References Cited</b>	Application/Control No. 10/644,858	Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
	Examiner John T. Kwon	Art Unit 3747	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-4,800,861	01-1989	Oshizawa et al.	123/506
	C	US-4,266,261	05-1981	Streit et al.	361/154
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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